

University of California
College of Engineering
Department of Electrical Engineering
and Computer Sciences

EECS 239
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9:30 AM-12:30 PM

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NAME _____

FINAL EXAM

Problem 1	_____
Problem 2	_____
Problem 3	_____
Problem 4	_____
TOTAL	_____

There are four problems, each having equal weight.

Problem 1. Capacitive RF Discharge Equilibrium

Design a symmetric, parallel plate, capacitive rf discharge in argon gas at a pressure $p = 3$ mTorr with a plate separation $l = 10$ cm, having an ion flux at the plasma-sheath edge of $\Gamma_{+s} = 5 \times 10^{19}$ ions/m²-s and an ion bombarding energy of $\varepsilon_i = 200$ V. To do this, choose an appropriate operating frequency f (Hz) and applied rf voltage amplitude V_{rf} (V) across the discharge electrodes. As in Example 1 of Chapter 11, the pressure is in the intermediate regime such that $l > \lambda_i > (T_i/T_e)l$, where λ_i is the ion-neutral mean free path. Assume that the sheath is collisionless, $s \ll \lambda_i$, and that stochastic heating dominates over ohmic heating. Also find the total power absorbed per unit area, S_{abs} (W/m²), and find the sheath width s (m) for your design.

Problem 2. Particle Balance in an N₂ Discharge

Consider a nitrogen (N₂) plasma chemistry in a steady state, low pressure rf inductive discharge. The discharge is a cylinder of radius R and length L . You may assume that the densities of all species (charged and neutral) are constant within the cylinder. Consider first the volume reactions with their second order rate coefficients [m³/s]



In addition, the first order rate coefficients [s⁻¹] for loss of N₂⁺, N⁺, and N to the cylinder surfaces are $K_{N_2^+}$, K_{N^+} and K_N , respectively.

- (a) Give the three rate equations for dn_α/dt , where $\alpha = N_2^+$, N⁺ and N, in terms of the rate coefficients and the concentrations n_e , n_{N_2} and n_α .

- (b) In the steady state, find n_N , n_{N^+} , and $n_{N_2^+}$ in terms of n_e , n_{N_2} , and the rate coefficients.

- (c) Assume that all volume second order rate coefficients have an Arrhenius form $K_\alpha = K_{\alpha 0} \exp(-\mathcal{E}_\alpha/T_e)$. Find the equation that determines the electron temperature T_e of the discharge, for a given n_e , n_{N_2} , and set of rate coefficients. **Do not try to solve for T_e .**

Problem 3. High Pressure Singlet Molecular Oxygen Source

The metastable species singlet molecular oxygen (SMO) can be used to clean surfaces such as silicon wafers, printed circuit boards, and clothes. SMO is an excited molecular metastable state ($^1\Delta_g$) of O_2 (see Table 8.1 of text) with an intrinsic lifetime of 4400 seconds. SMO can be made in a plane parallel O_2 discharge operating at atmospheric pressure (760 Torr) and room temperature (300 K). No vacuum pump is used.

To estimate the generation and loss of SMO, consider a one-dimensional model with parallel plates located at $x = -l/2$ and $x = l/2$, where $l = 0.1$ cm. Assume that SMO is created in the volume by reaction 15 (Table 8.2), $e + O_2 \rightarrow O_2^* + e$, with rate coefficient $K_{15} = 1.37 \times 10^{-10} e^{-2.14/T_e}$ cm^3/s and is lost from the volume by reaction 18 (Table 8.2), $O_2^* + O_2 \rightarrow 2O_2$, with rate coefficient $K_{18} = 2.2 \times 10^{-18}$ cm^3/s . Because the discharge is highly electronegative, the electron density within the plates is uniform, $n_e(x) = n_{e0} = 10^8$ cm^{-3} , and $T_e \approx 2.14$ V. Neglect the volume loss of SMO due to its decay at its natural lifetime of 4400 s.

- (a) Assuming that all SMO molecules incident on the surfaces (plates) are reflected back into the discharge volume (zero sticking coefficient), find a numerical value for the SMO density n^* (cm^{-3}).

- (b) Give a numerical estimate for the actual lifetime (in seconds) of an SMO molecule in this discharge. Give a numerical estimate for the flux of SMO molecules ($\text{cm}^{-2}\text{-s}^{-1}$) incident on a surface.

- (c) Assume now that a fraction $\gamma = 0.2$ of all SMO molecules incident on the surfaces react at these surfaces and are lost from the system. Hence there is an additional diffusive loss of SMO molecules from the system. Give the diffusion equation that determines $n^*(x)$ and give an estimate for the diffusion coefficient D for diffusion of SMO molecules through the background (O_2) gas. Give a numerical estimate for D (cm^2/s). Finally, give the boundary conditions on n^* that are needed in order to solve the diffusion equation to determine $n^*(x)$. **Do not solve for $n^*(x)$.**

Problem 4. Etching of SiO₂ by CF₂ Radicals

Consider the following simple model of CF₂ chemical etching of an SiO₂ substrate having volume density n_{SiO_2} (m⁻³) and surface density n'_0 (m⁻²). Let θ_1 be the fraction of the surface sites that are bare SiO₂, θ_2 be the fraction covered with CO, and θ_3 be the fraction covered with SiF₄ ($\theta_1 + \theta_2 + \theta_3 = 1$). Let CF₂ radicals with gas phase density n_S (m⁻³) near the substrate adsorb on θ_1 to form CO + $\frac{1}{2}$ SiF₄, with the rate coefficient K_a (m³/s). Let CO molecules thermally desorb from θ_2 with rate coefficient K_{d2} (s⁻¹) and SiF₄ molecules thermally desorb from θ_3 with rate coefficient K_{d3} (s⁻¹).

- (a) Find the surface coverages θ_1 , θ_2 , and θ_3 , and find the chemical (horizontal) etch rate E_h (m/s).

- (b) Now assume that a flux $\Gamma_i = n_{i,s} u_B$ of ions is incident on the substrate surface, where u_B is the Bohm velocity. This flux produces an ion enhanced desorption of CO and SiF₄, having a yield Y_2 of desorbed CO molecules and Y_3 SiF₄ molecules per incident ion. In addition, there is thermal desorption of CO and SiF₄ as in part (a). Find the ion enhanced (vertical) etch rate E_v .